

SEP 05 2002

LIST OF PRIOR ART CITED BY APPLICANT
(Use Several Sheets If Necessary)

Sheet 1 of 1

Atty. Docket No.
106780 / LeA 35,006Serial No.
10/076,583Applicant
Patrick Enewoldsen et alFiling Date
February 15, 2002Group
1773

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|------------------|----|-----------------|----------|---------------|-------|----------|----------------------------|
| <i>LL</i> | AA | 4,707,396 | 11/17/87 | Wank et al | 428 | 216 | |
| | AB | 5,437,755 | 08/01/95 | Lavorel et al | 156 | 240 | |
| | AC | 5,658,647 | 08/19/97 | Magill et al | 428 | 195 | |
| | AD | | | | | | |
| | AE | | | | | | |
| | AF | | | | | | |
| | AG | | | | | | |
| | AH | | | | | | |
| | AI | | | | | | |
| | AJ | | | | | | |
| | AK | | | | | | |

FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION | |
|-----------|----|-----------------|----------|---------------------------|-------|----------|-------------|-----|
| | | | | | | | Yes | No* |
| <i>LL</i> | AL | 61-64483 | 04/02/86 | Japan (Abstract Attached) | | | | X |
| | AM | | | | | | | |
| | AN | | | | | | | |
| | AO | | | | | | | |
| | AP | | | | | | | |

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

| | | | |
|-----------------|----|--|-----------|
| EXAMINER | AR | | |
| | | | |
| | | | |
| EXAMINER | AS | | |
| | | | |
| | | | |
| EXAMINER | AT | | |
| | | | |
| | | | |
| DATE CONSIDERED | | | <i>LL</i> |

EXAMINER Initial if referenced considered, whether or not citation is in conformance with MPEP 609: Draw line through if not in conformance and not considered. Include copy of this form with next communication to applicant.

Neither English Language Equivalent nor an English Language Translation is available.

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